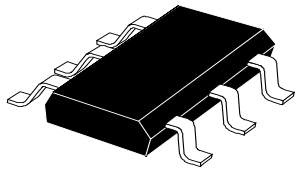
STT4PF20V

P-CHANNEL 20V - 0.090 Ω - 3A SOT23-6L
2.7V-DRIVE STripFET™ II POWER MOSFET

TYPE	V_{DSS}	$R_{DS(on)}$	I_D
STT4PF20V	20 V	< 0.11 Ω (@ 4.5 V) < 0.135 Ω (@ 2.7 V)	3 A

- TYPICAL R_{DS}(on) = 0.090 Ω @ 4.5 V
- TYPICAL R_{DS}(on) = 0.100 Ω @ 2.7 V
- ULTRA LOW THRESHOLD GATE DRIVE (2.7 V)
- STANDARD OUTLINE FOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY



SOT23-6L

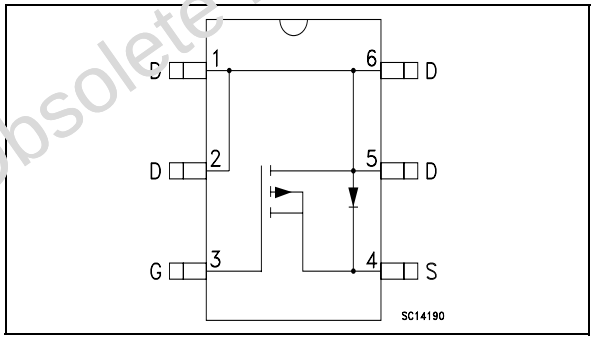
DESCRIPTION

This Power MOSFET is the latest development of STMicroelectronis unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

APPLICATIONS

- MOBILE PHONE APPLICATIONS
- DC-DC CONVERTERS
- BATTERY MANAGEMENT IN NOMADIC EQUIPMENT

INTERNAL SCHEMATIC DIAGRAM



Obsolete Product(s) - Obsolete Product(s)

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source Voltage (V_{GS} = 0)	20	V
V_{DGR}	Drain-gate Voltage (R_{GS} = 20 kΩ)	20	V
V_{GS}	Gate- source Voltage	± 10	V
I_D	Drain Current (continuous) at T_C = 25°C	3	A
I_D	Drain Current (continuous) at T_C = 100°C	1.9	A
I_{DM}(•)	Drain Current (pulsed)	12	A
P_{tot}	Total Dissipation at T_C = 25°C	1.6	W

(•) Pulse width limited by safe operating area.

Note: For the P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

THERMAL DATA

$R_{thj\text{-}amb}$	(*)Thermal Resistance Junction-ambient	Max	78	°C/W
T_j	Maximum Operating Junction Temperature		150	°C
T_{stg}	storage temperature		-55 to 150	°C

(*) When Mounted on 1 inch^2 FR-4 board, 2 oz of Cu and t ≤ 10 sec.

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

OFF

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source Breakdown Voltage	I_D = 250 µA, V_{GS} = 0	20			V
I_{DSS}	Zero Gate Voltage Drain Current (V_{GS} = 0)	V_{DS} = Max Rating V_{DS} = Max Rating T_C = 125°C			1 10	µA µA
I_{GSS}	Gate-body Leakage Current (V_{DS} = 0)	V_{GS} = ± 10V			±100	nA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS} I_D = 250 µA	0.6			V
$R_{DS(on)}$	Static Drain-source On Resistance	V_{GS} = 4.5 V I_D = 1.5 A V_{GS} = 2.7 V I_D = 1.5 A		0.090 0.100	0.110 0.135	Ω Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
g_{fs} (*)	Forward Transconductance	V_{DS}=15V I_D=1.5 A		6.5		S
C_{iss} C_{oss} C_{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V_{DS} = 15V, f = 1 MHz, V_{GS} = 0		500 140 30		pF pF pF

Obsolete Product(s) - Obsolete Product(s)

ELECTRICAL CHARACTERISTICS (continued)

SWITCHING ON(*)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r	Turn-on Delay Time Rise Time	V_{DD} = 10 V I_D = 1.5 A R_G = 4.7 Ω V_{GS} = 4.5 V (Resistive Load, Figure 1)		38 39		ns ns
Q_g Q_{gs} Q_{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	V_{DD}= 10V I_D= 3A V_{GS}=4.5V (see test circuit, Figure 2)		5.8 1 1.4	7.8	nC nC nC

SWITCHING OFF(*)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(off)}$ t_f	Turn-off Delay Time Fall Time	V_{DD} = 10 V I_D = 1.5 A R_G = 4.7Ω, V_{GS} = 4.5 V (Resistive Load, Figure 1)		54 12		ns ns

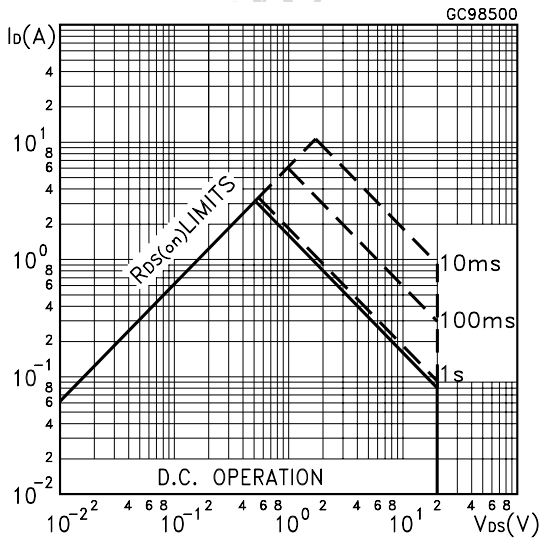
SOURCE DRAIN DIODE(*)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD} I_{SDM} (•)	Source-drain Current Source-drain Current (pulsed)				3 12	A A
V_{SD} (*)	Forward On Voltage	I_{SD} = 3 A V_{GS} = 0			1.2	V
t_{rr} Q_{rr} I_{RRM}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	I_{SD} = 3 A di/dt = 100A/µs V_{DD} = 15 V T_j = 150°C (Inductive Load, Figure 3)		20 13 1.3		ns nC A

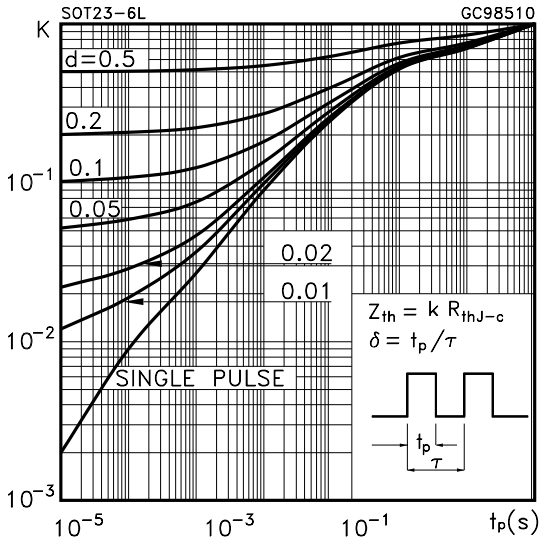
(*)Pulse width ≤ 300 µs, duty cycle 1.5 %.
(•)Pulse width limited by T_{JMAX}

Obsolete Product(s) - Obsolete Product(s)

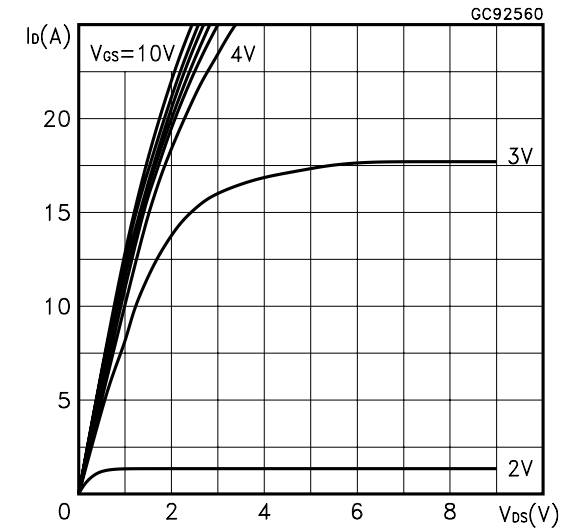
Safe Operating Area



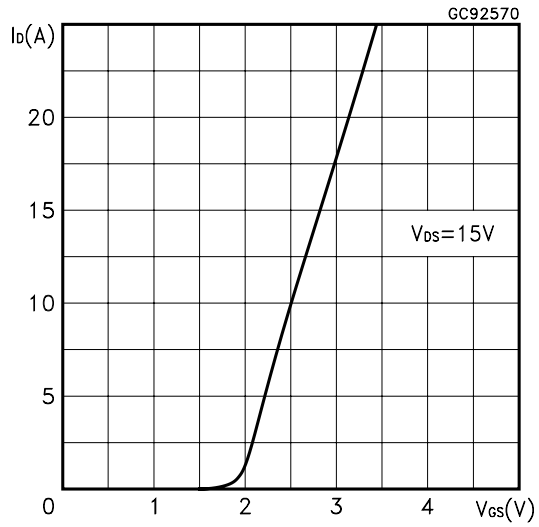
Thermal Impedance



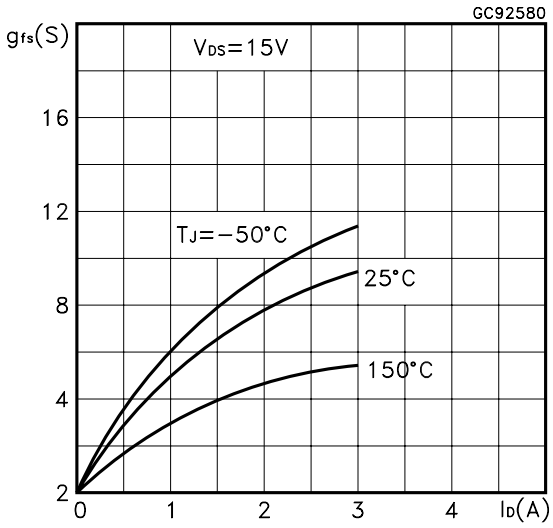
Output Characteristics



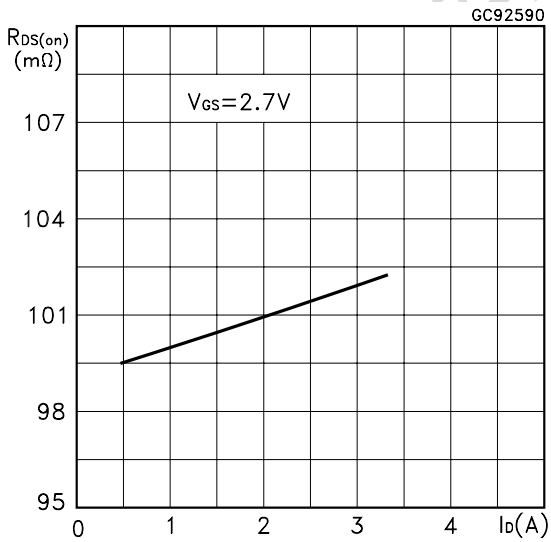
Transfer Characteristics



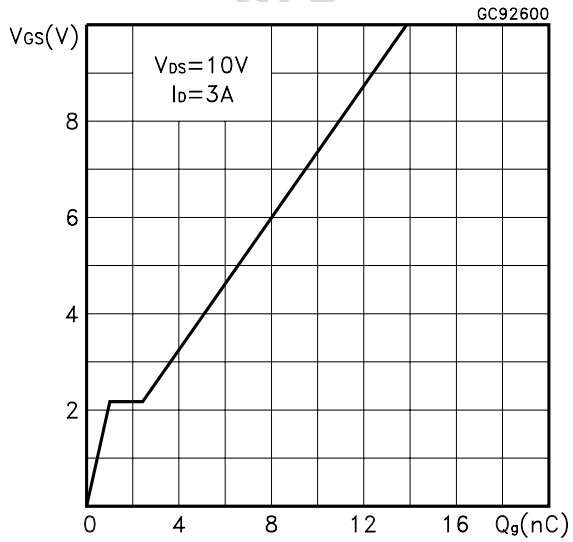
Transconductance



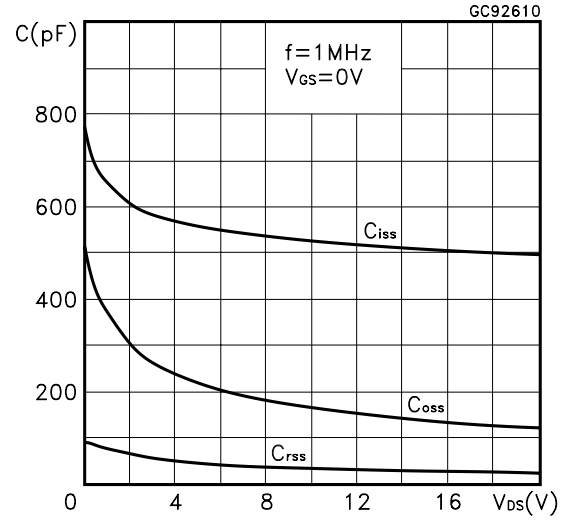
Static Drain-source On Resistance



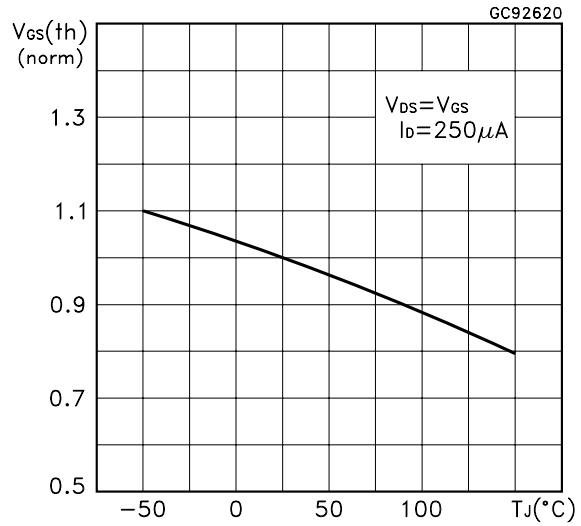
Gate Charge vs Gate-source Voltage



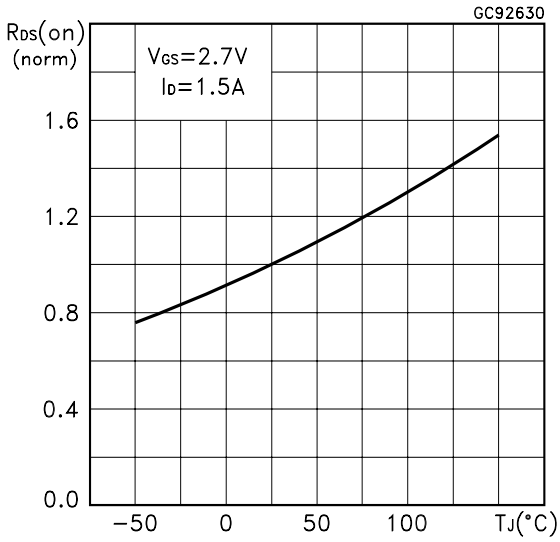
Capacitance Variations



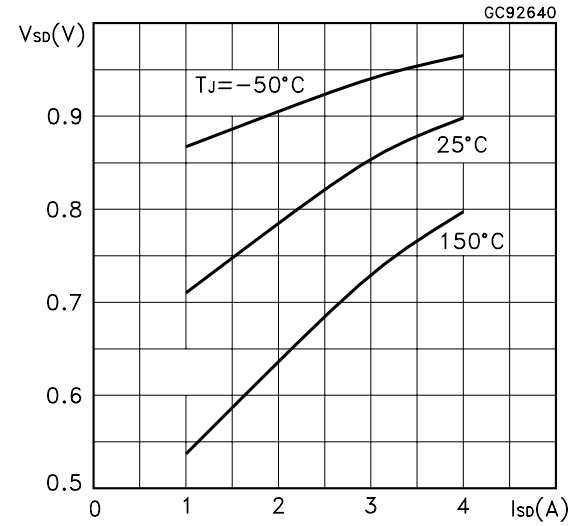
Normalized Gate Threshold Voltage vs Temperature



Normalized on Resistance vs Temperature



Source-drain Diode Forward Characteristics



Normalized Breakdown Voltage vs Temperature

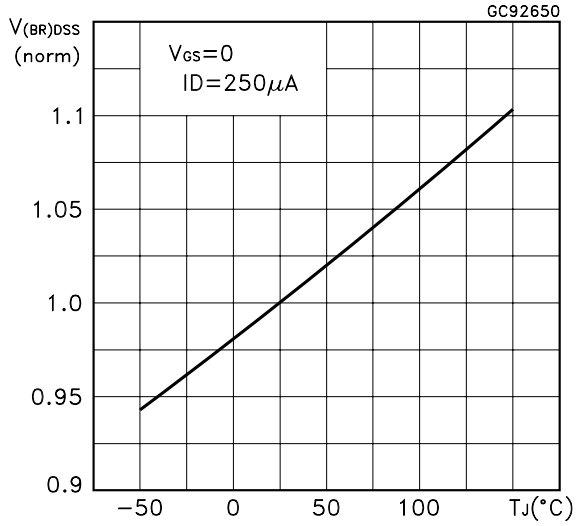


Fig. 1: Switching Times Test Circuits For Resistive Load

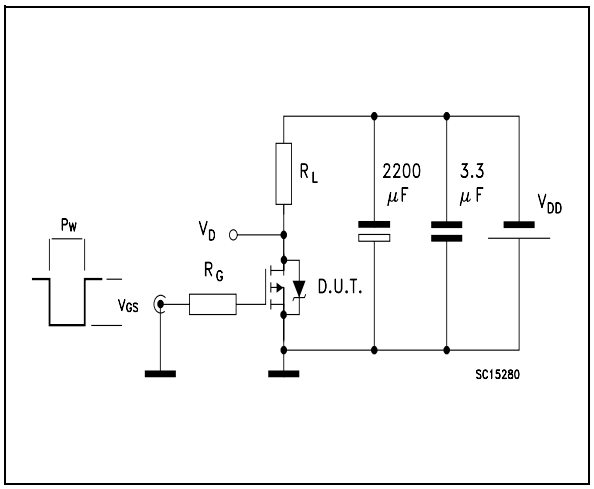


Fig. 2: Gate Charge test Circuit

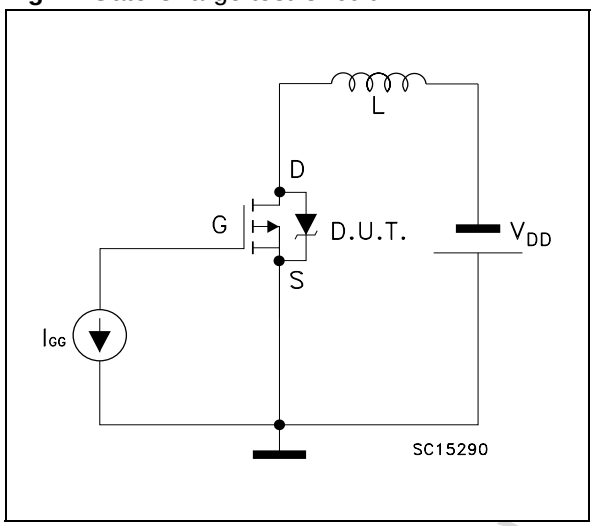
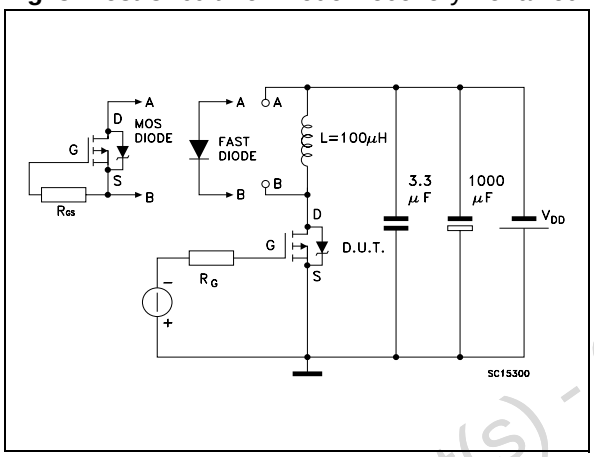


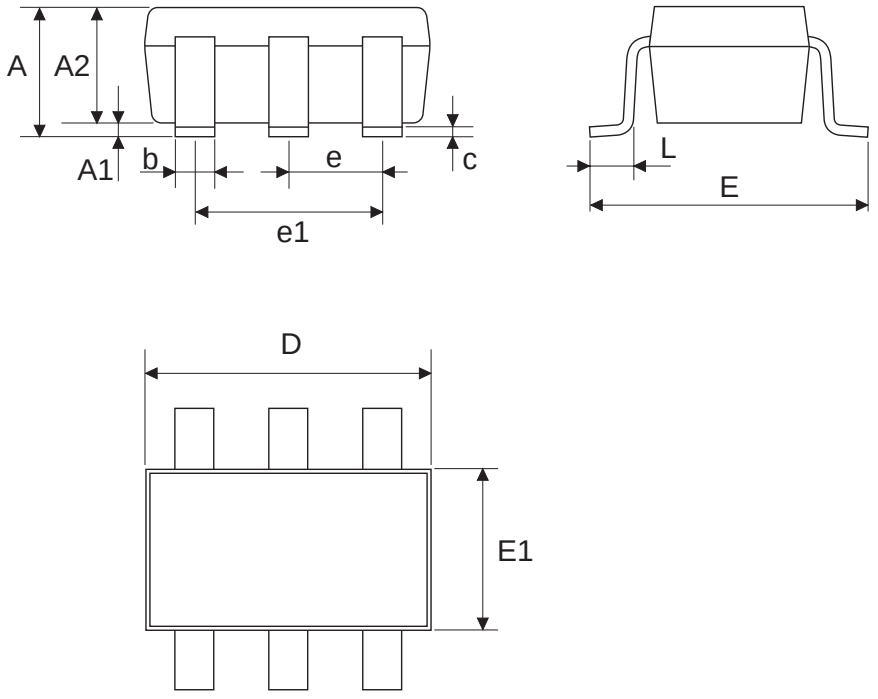
Fig. 3: Test Circuit For Diode Recovery Behaviour



Obsolete Product(s) - Obsolete Product(s)

SOT23-6L MECHANICAL DATA

DIM.	mm			mils		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	0.90		1.45	0.035		0.057
A1	0.00		0.15	0.000		0.006
A2	0.90		1.30	0.035		0.051
b	0.25		0.50	0.010		0.020
C	0.09		0.20	0.004		0.008
D	2.80		3.10	0.110		0.122
E	2.60		3.00	0.102		0.118
E1	1.50		1.75	0.059		0.069
L	0.35		0.55	0.014		0.022
e		0.95			0.037	
e1		1.90			0.075	



Obsolete Product(s) - Obsolete Product(s)

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